Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
10/526,337	NAKAMURA ET AL.	T AL.	
Examiner	Art Unit		
Khoa D. Huynh	3751		

SEARCHED						
Class	Subclass	Date	Examiner			
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INTERFERENCE SEARCHED					
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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